

Search Notes

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Examiner

John Q. Nguyen

Applicant(s)/Patent under
Reexamination

ISHIHARA ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
Previous search updated		3/8/2007	JN

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR